DATA SHEET

NEC

MOS FIELD EFFECT TRANSISTORS

2SK2359/2SK2360

SWITCHING
N-CHANNEL POWER MOS FET
INDUSTRIAL USE

DESCRIPTION

The 2SK2359, 2SK2359-Z/2SK2360, 2SK2360-Z is N-Channel MOS Field Effect Transistor designed for high voltage switching applications.

FEATURES

- Low On-Resistance
  - 2SK2359: $R_{DS(on)}$ = 0.9 Ω (V_{GS} = 10 V, I_D = 4.0 A)
  - 2SK2360: $R_{DS(on)}$ = 1.0 Ω (V_{GS} = 10 V, I_D = 4.0 A)
- Low C_{iss} C_{iss} = 1050 pF TYP.
- High Avalanche Capability Ratings

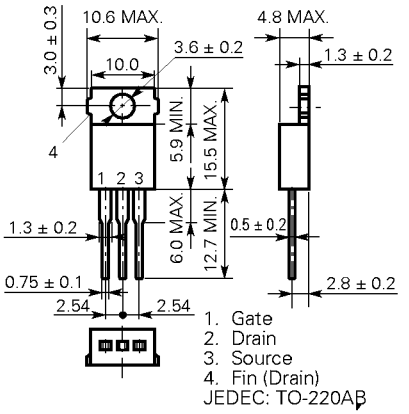
ABSOLUTE MAXIMUM RATINGS (T_A = 25 °C)

Drain to Source Voltage(2SK2359/2SK2360)	V_{DSS}	450/500	V
Gate to Source Voltage	V_{GSS}	±30	V
Drain Current (DC)	$I_{D(DC)}$	±7.0	A
Drain Current (pulse)*	$I_{D(pulse)}$	±28	A
Total Power Dissipation (T_C = 25 °C)	P_{T1}	75	W
Total Power Dissipation (T_A = 25 °C)	P_{T2}	1.5	W
Channel Temperature	T_{ch}	150	°C
Storage Temperature	T_{stg}	–55 to +150	°C
Single Avalanche Current**	I_{AS}	7.0	A
Single Avalanche Energy**	E_{AS}	17	mJ

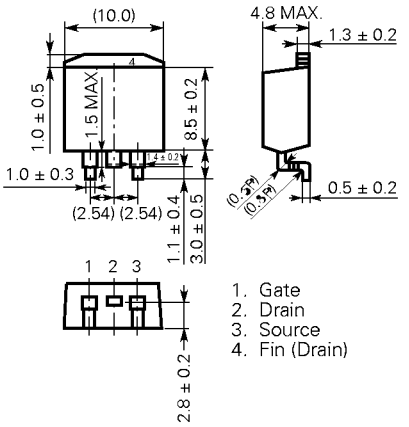
* PW ≤ 10 μs, Duty Cycle ≤ 1 %

** Starting T_{ch} = 25 °C, R_G = 25 Ω, V_{GS} = 20 V → 0

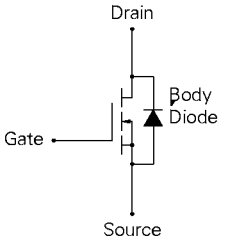
PACKAGE DIMENSIONS
(in millimeters)



MP-25 (TO220)



MP-25Z (SURFACE MOUNT TYPE)



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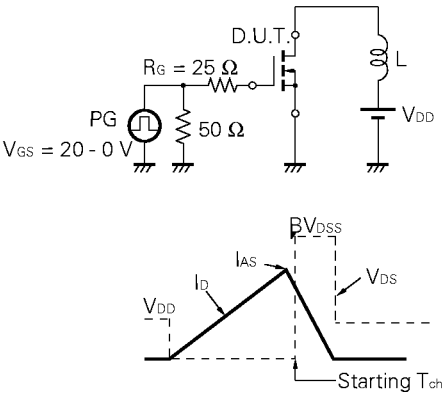
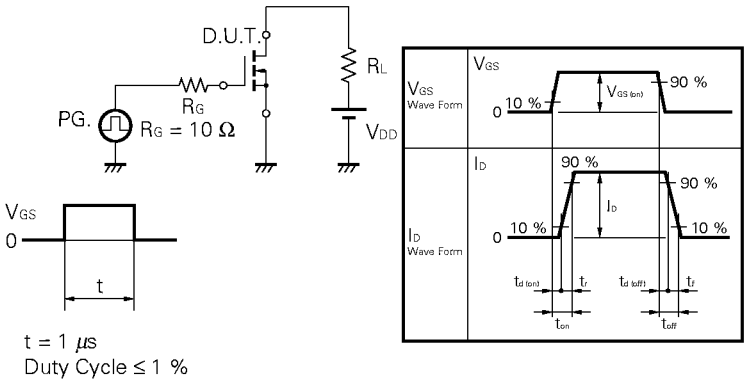
ELECTRICAL CHARACTERISTICS (T_A = 25 °C)

CHARACTERISTIC	SYMBOL	MIN.	TYP.	MAX.	UNIT	TEST CONDITIONS	
Drain to Source On-State Resistance	$R_{DS(on)}$		0.7	0.9	mΩ	V_{GS} = 10 V	2SK2359
			0.8	1.0		V_D = 4.0 V	2SK2360
Gate to Source Cutoff Voltage	$V_{GS(off)}$	2.5		3.5	V	V_{DS} = 10 V, I_D = 1 mA	
Forward Transfer Admittance	$\|y_{fs}\|$	3.0			S	V_{DS} = 10 V, I_D = 4.0 A	
Drain Leakage Current	I_{DSS}			100	μA	V_{DS} = V_{DSS}, V_{GS} = 0	
Gate to Source Leakage Current	I_{GSS}			±100	nA	V_{GS} = ±30 V, V_{DS} = 0	
Input Capacitance	C_{iss}		1050		pF	V_{DS} = 10 V	
Output Capacitance	C_{oss}		200		pF	V_{GS} = 0	
Reverse Transfer Capacitance	C_{rss}		26		pF	f = 1 MHz	
Turn-On Delay Time	$t_{d(on)}$		14		ns	I_D = 4.0 A	
Rise Time	t_r		9		ns	V_{GS} = 10 V	
Turn-Off Delay Time	$t_{d(off)}$		56		ns	V_{DD} = 150 V	
Fall Time	t_f		14		ns	R_G = 10 Ω R_L = 37.5 Ω	
Total Gate Charge	Q_G		27		nC	I_D = 7.0 A	
Gate to Source Charge	Q_{GS}		5.5		nC	V_{DD} = 400 V	
Gate to Drain Charge	Q_{GD}		12		nC	V_{GS} = 10 V	
Body Diode Forward Voltage	$V_{F(S-D)}$		1.0		V	I_F = 7.0 A, V_{GS} = 0	
Reverse Recovery Time	t_{rr}		300		ns	I_F = 7.0 A, V_{GS} = 0	
Reverse Recovery Charge	Q_{rr}		1.5		μC	di/dt = 50 A/μs	

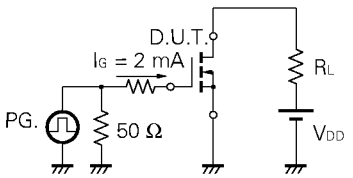
Test Circuit 1 Avalanche Capability



Test Circuit 2 Switching Time



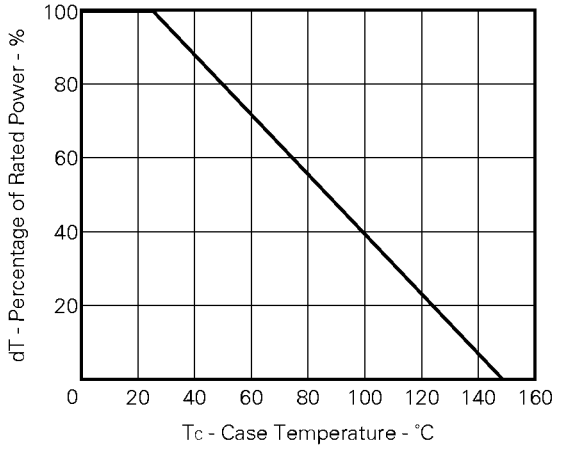
Test Circuit 3 Gate Charge



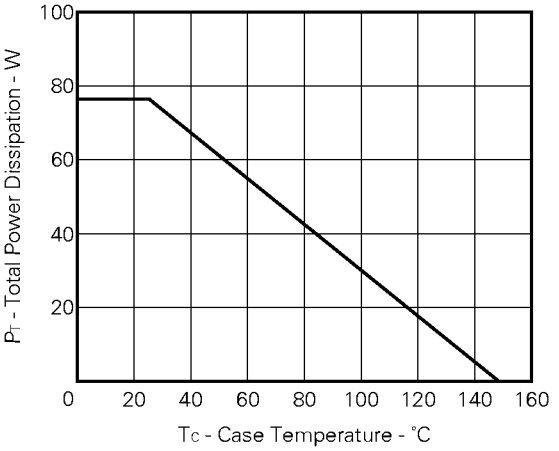
The application circuits and their parameters are for references only and are not intended for use in actual design-in's.

TYPICAL CHARACTERISTICS (T_A = 25 °C)

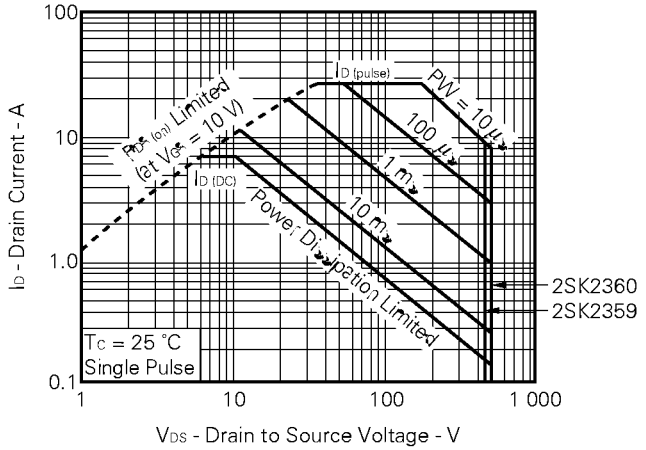
DERATING FACTOR OF FORWARD BIAS SAFE OPERATING AREA



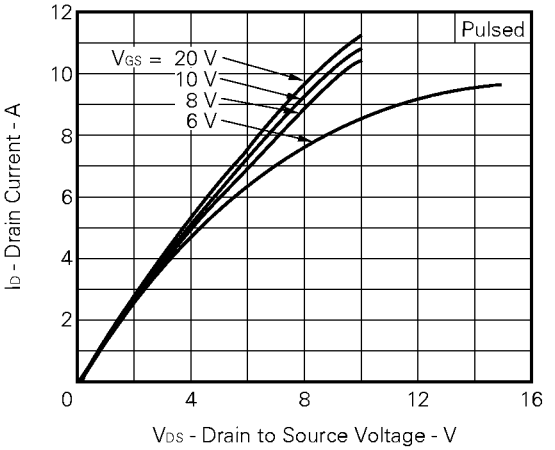
TOTAL POWER DISSIPATION vs. CASE TEMPERATURE



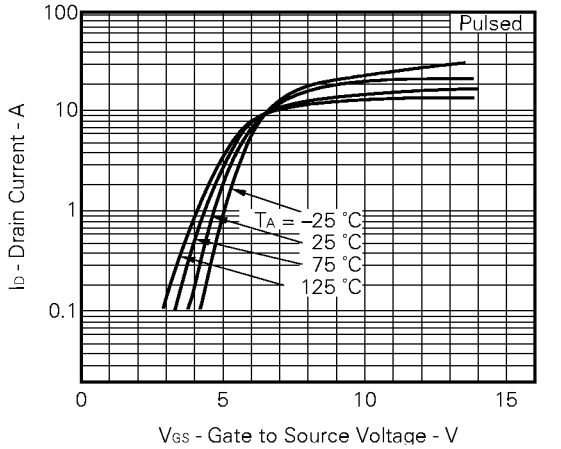
FORWARD BIAS SAFE OPERATING AREA



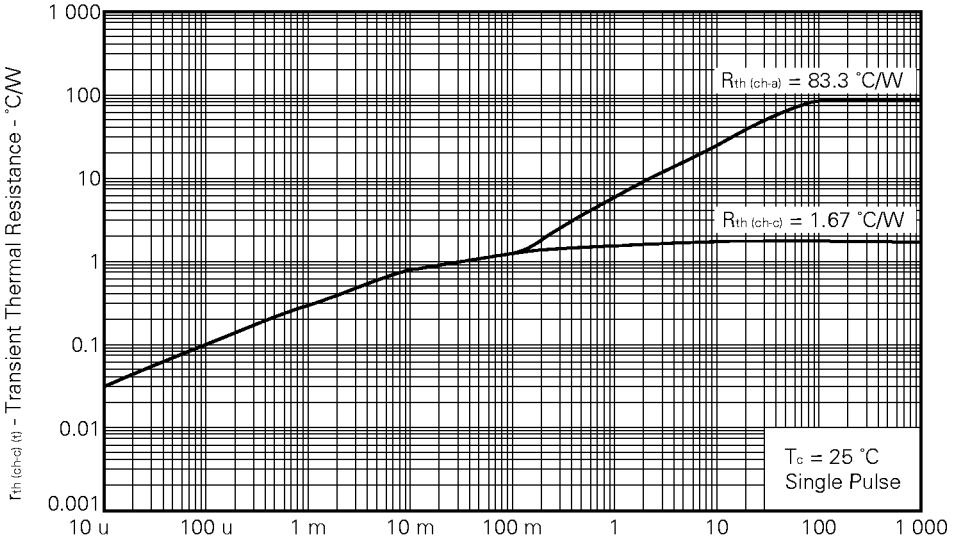
DRAIN CURRENT vs. DRAIN TO SOURCE VOLTAGE



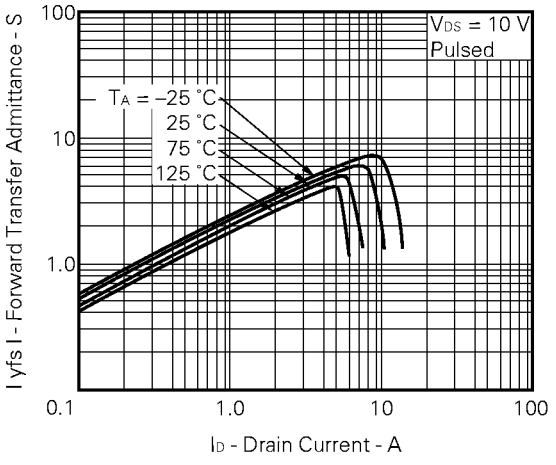
DRAIN CURRENT vs. GATE TO SOURCE VOLTAGE



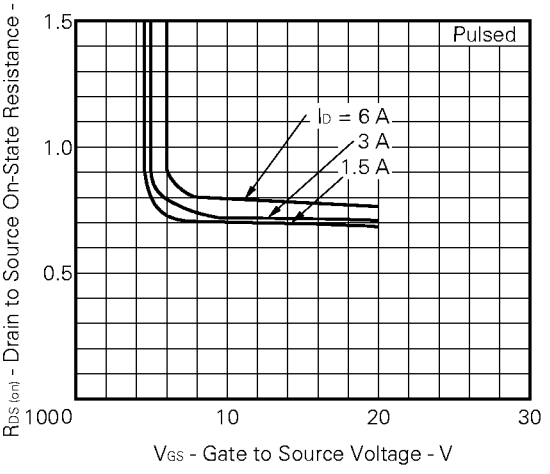
TRANSIENT THERMAL RESISTANCE vs. PULSE WIDTH



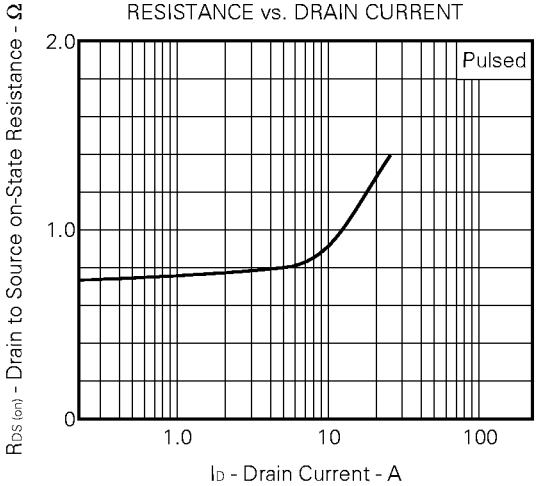
FORWARD TRANSFER ADMITTANCE vs. DRAIN CURRENT



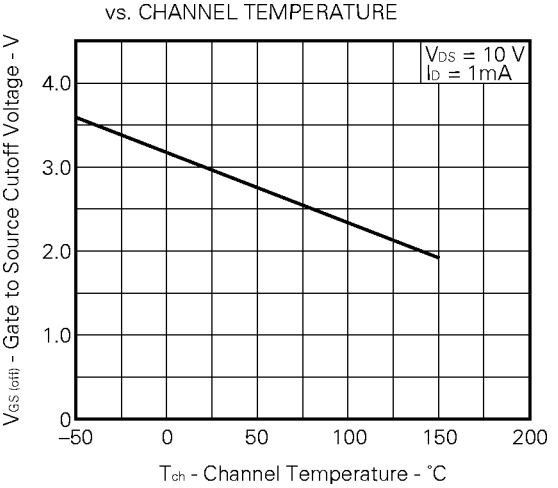
DRAIN TO SOURCE ON-STATE RESISTANCE vs. GATE TO SOURCE VOLTAGE



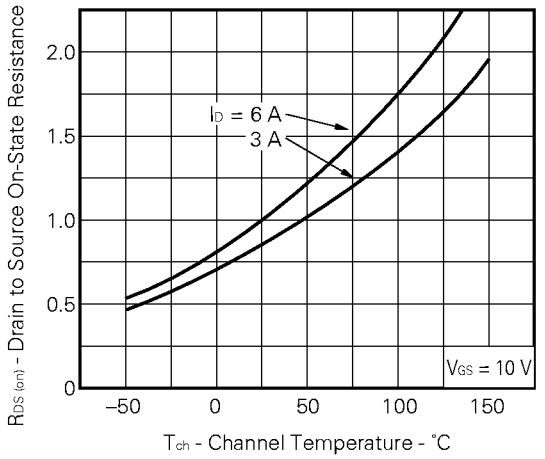
DRAIN TO SOURCE ON-STATE RESISTANCE vs. DRAIN CURRENT



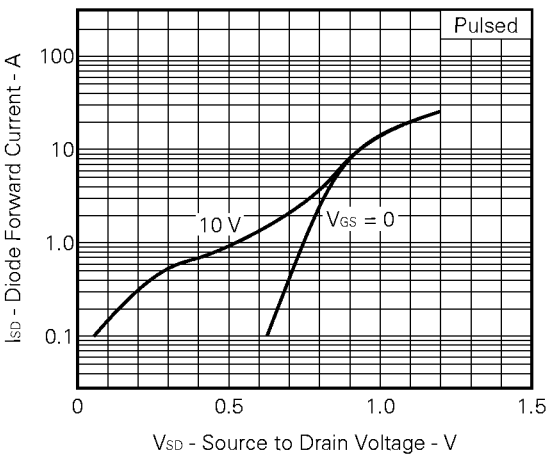
GATE TO SOURCE CUTOFF VOLTAGE vs. CHANNEL TEMPERATURE



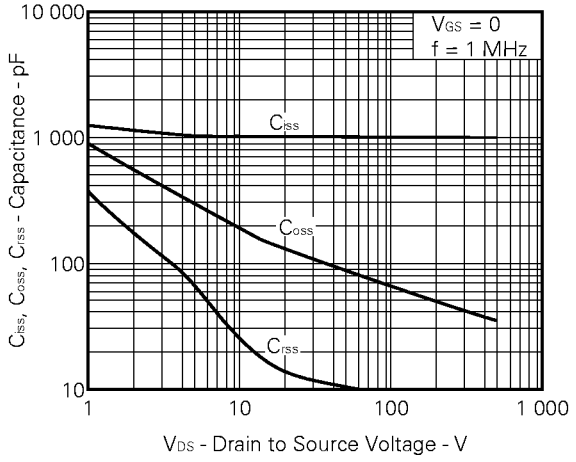
DRAIN TO SOURCE ON-STATE RESISTANCE vs. CHANNEL TEMPERATURE



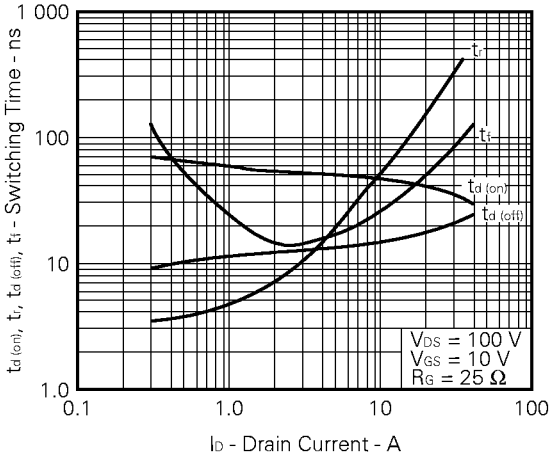
SOURCE TO DRAIN DIODE FORWARD VOLTAGE



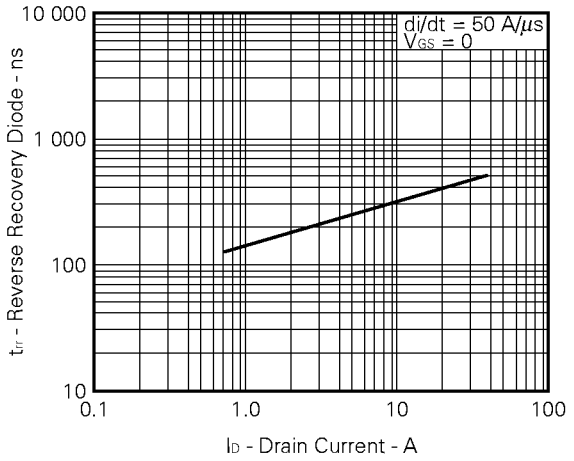
CAPACITANCE vs. DRAIN TO SOURCE VOLTAGE



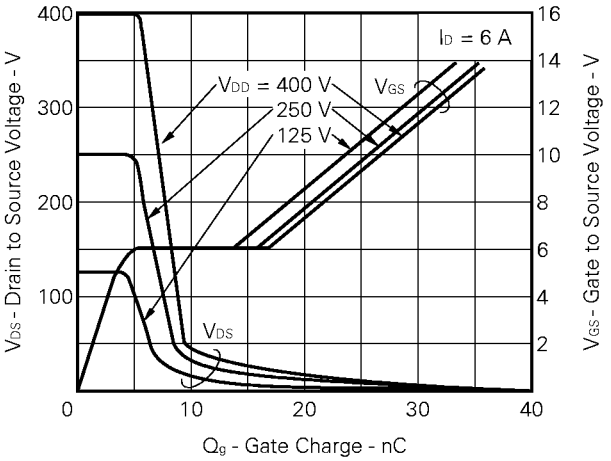
SWITCHING CHARACTERISTICS



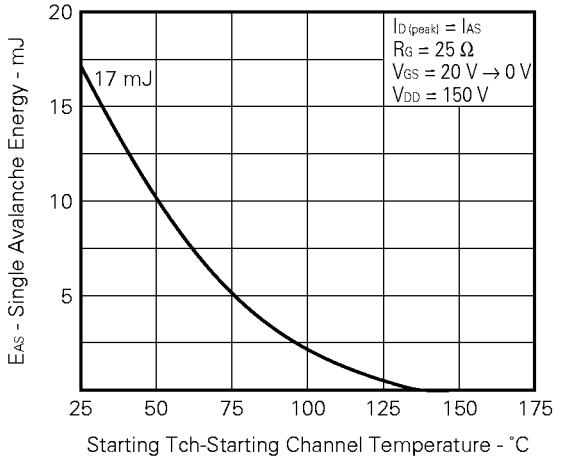
REVERSE RECOVERY TIME vs. DRAIN CURRENT



DYNAMIC INPUT/OUTPUT CHARACTERISTICS



SINGLE AVALANCHE ENERGY vs.
STARTING CHANNEL TEMPERATURE



SINGLE AVALANCHE CURRENT vs.
INDUCTIVE LOAD